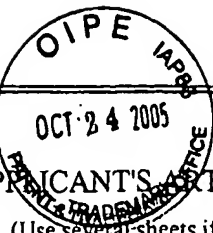


APPLICANT'S ART CITATION (Use several sheets if necessary)		Application 10/769,159		OFGS File No. P/923-374		
		Applicant Byoung-Ok MIN				
		Filing Date January 29, 2004		Group Art Unit 2879		
U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)						
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
	US-					
	US-					
	US-					
	US-					
	US-					
	US-					
	US-					
	US-					
	US-					
	US-					
FOREIGN PATENT DOCUMENTS						
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation
						Yes No
<i>OK</i>	2000-353495	12-2000	Japan			Abstract
<i>OK</i>	2001-338620	12-2001	Japan			Abstract
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
<i>OK</i>	Untranslated Office Action issued by Japanese Patent Office on October 18, 2005					
	in connection with corresponding Japanese patent application no. 2004-057722					
Examiner	<i>Andy G</i>		Date Considered 6 March 2006			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.						



APPLICANT'S PATENT CITATION

(Use several sheets if necessary)

Application 10/769,159

OFGS File No. P/923-374

Applicant Byoung-Ok MIN

Filing Date January 29, 2004

Group Art Unit 2879

U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)

Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
<i>Ch</i>	US-2003/0057841 A1	03-2003	Kang			
<i>Ch</i>	US-5,334,913	08-1994	Ury, et. al.			
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	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
<i>Ch</i>	2002-0054161	07-2002	Korea			Abstract	
<i>Ch</i>	2001-302338	10-2001	Japan			Abstract	
<i>Ch</i>	2001-283780	10-2001	Japan			Abstract	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>Ch</i>		Search Report issued on August 30, 2005 by European Patent Office in connection with
		corresponding application no. EP 04 29 0009.2
		English Abstract for European patent application no. EP 04 29 0009.2

Examiner *Anthony S.*

Date Considered

8 March 2006

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